

Notice of References Cited	Application/Control No. 09/365,748		Applicant(s)/Patent Under Reexamination BEDNAREK, MICHAEL DAVID	
	Examiner Jean D Janvier		Art Unit 3622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,937,391	08-1999	Ikeda et al.	705/14
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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